

Notice of References Cited	Application/Control No. 10/649,617	Applicant(s)/Patent Under Reexamination KANEMOTO ET AL.	
	Examiner Anthony Weier	Art Unit 1761	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,488,481	12-1984	Satake, Toshihiko	99/517
	B	US-6,832,545	12-2004	Satake et al.	99/518
	C	US-4,148,251	04-1979	Satake, Toshihiko	99/519
	D	US-5,773,066	06-1998	Satake et al.	426/483
	E	US-4,741,913	05-1988	Satake, Toshihiko	426/483
	F	US-5,520,949	05-1996	Lewis et al.	426/618
	G	US-5,119,721	06-1992	Satake et al.	99/519
	H	US-5,773,066	06-1998	Satake et al.	426/483
	I	US-3,523,025	08-1970	MCGINLEY FLANN A	426/271
	J	US-1,377,125	05-1921	GURJAR ANANT M	426/627
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.